

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. 00862.109526.		INTERNATIONAL APPLICATION NO PCT/JP2005/004851		
			APPLICANT HIROSHI KAJIWARA ET AL.		28 JUL 2006		
			INTERNATIONAL FILING DATE March 11, 2005		GROUP 2624		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
/E.Y./	JPA	04-207280	7/29/92	JAPAN			Abstract
/E.Y./	JPA	05-191800	7/30/93	JAPAN			Abstract
/E.Y./	JPA	02-309777	12/25/90	JAPAN			Abstract
/E.Y./	JPA	2000-013797	1/14/00	JAPAN			Abstract & corresponding U.S. Patent
/E.Y./	JPA	2003-115765	4/18/03	JAPAN			Abstract
/E.Y./	JPA	2004-056632	2/19/04	JAPAN			Abstract
/E.Y./	JPA	2002-325257	11/8/02	JAPAN			Abstract & corresponding EP & U.S. Patent
/E.Y./	JPA	2000-125304	4/28/00	JAPAN			Abstract
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/E.Y./	JPA	03-006187	1/11/91	JAPAN			Abstract
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OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER	/Eueng Nan Yeh/			DATE CONSIDERED	07/02/2009		

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PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)ATTY DOCKET NO.
00862.109526.APPLICATION NO.
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March 11, 2005

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TAP5 Rec'd 5/7/10 28 JUL 2006

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
/E.Y./	EP	1 233 625 A2	8/21/02	EPO			English

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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